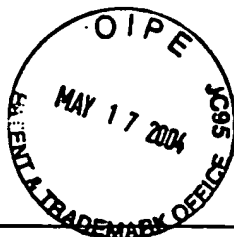


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DP-309186Serial No.  
10/763,824Applicant  
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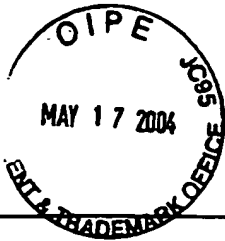
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Lindsey Dickerson

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January 23, 2004

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7/6/06

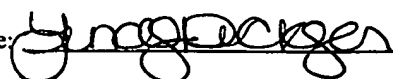
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Filing Date January 23, 2004	Group

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## INFORMATION DISCLOSURE CITATION WITH DOCUMENT COPIES

Submitted by:	Atty. Docket No. DP-309186	Serial No. 101763824
SCOTT A. MCBAIN Delphi Technologies, Inc.,	Applicant Van Steenkiste, et al	
Reg. No. 37181	Filing Date <del>Here with</del> 1/23/04	Group 3752

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Examiner: [Signature] Date Considered: 1/6/04

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SCOTT A. MCBAIN Delphi Technologies, Inc.,	Applicant Van Steenkiste, et al	
Reg. No. 37181	Filing Date Herewith	Group

**U.S. PATENT DOCUMENTS**

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Document Number	Date	Country	Class	Subclass	Translation Yes   No

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Van Steenkiste, et al

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**U.S. PATENT DOCUMENTS**

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Louise Twen

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